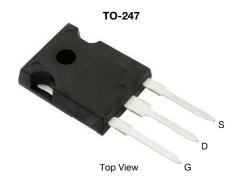




# N-Channel 150 V (D-S) 175 °C MOSFET



PRODUCT SUMMARY			
V <sub>DS</sub> (V)	150		
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 10 \text{ V}$	0.0054		
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 7.5 \text{ V}$	0.0060		
Q <sub>g</sub> typ. (nC)	110		
I <sub>D</sub> (A)	100 <sup>d</sup>		
Configuration	Single		

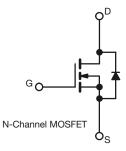
#### **FEATURES**

- ThunderFET® power MOSFET
- Low R<sub>DS</sub> Q<sub>g</sub> figure-of-merit (FOM)
- Maximum 175 °C junction temperature
- 100 % R<sub>a</sub> and UIS tested
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

## RoHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- Synchronous rectification
- Power supplies
- DC/AC inverter
- DC/DC converter
- · Solar micro inverter
- · Motor drive switch



ORDERING INFORMATION			
Package	TO-247		
Lead (Pb)-free and halogen-free	SUG80050E-GE3		

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V <sub>DS</sub>	150	
Gate-source voltage		V <sub>GS</sub>	± 20	V
Continuous drain current	T <sub>C</sub> = 25 °C		100 <sup>d</sup>	
	T <sub>C</sub> = 125 °C	l <sub>D</sub>	18.1	
Pulsed drain current (t = 100 μs)		I <sub>DM</sub>	300	A
Continuous source-drain diode current		I <sub>S</sub>	100 <sup>d</sup>	
Single pulse avalanche current <sup>a</sup>	1 0411	I <sub>AS</sub>	100	
Single pulse avalanche energy <sup>a</sup>	L = 0.1 mH	E <sub>AS</sub>	500	mJ
Maximum power dissipation	T <sub>C</sub> = 25 °C	Б	500 <sup>b</sup>	14/
	T <sub>C</sub> = 125 °C	P <sub>D</sub>	167 <sup>b</sup>	— W
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	%0
Soldering recommendations (peak temperature) c			260	°C

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	MAXIMUM	UNIT	
Maximum junction-to-ambient (PCB mount) c		R <sub>thJA</sub>	40	°C/W	
Maximum junction-to-case (drain)	Steady state	R <sub>thJC</sub>	0.3		

#### Notes

- a. Duty cycle ≤ 1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).
- d. Package limited.



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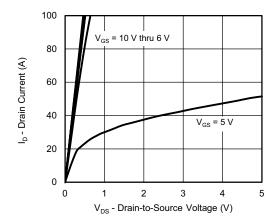
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	150	-	-	V	
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	-	4	V	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	250	nA	
Zero gate voltage drain current		$V_{DS} = 150 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μA mA	
	$I_{DSS}$	$V_{DS} = 150 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$	-	-	150		
		$V_{DS}$ = 150 V, $V_{GS}$ = 0 V, $T_J$ = 175 °C	-	-	5		
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	30	-	-	Α	
Drain-source on-state resistance <sup>a</sup>		$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	0.0045	0.0054		
	R <sub>DS(on)</sub>	$V_{GS} = 7.5 \text{ V}, I_D = 15 \text{ A}$	-	0.0050	0.0063	Ω	
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A	-	60	-	S	
Dynamic <sup>b</sup>							
Input capacitance	C <sub>iss</sub>		-	6250	-	pF	
Output capacitance	C <sub>oss</sub>	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	1100	-		
Reverse transfer capacitance	C <sub>rss</sub>		-	65	-		
Total gate charge	Qg		-	110	165	nC	
Gate-source charge	$Q_{gs}$	$V_{DS} = 75 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	33	-		
Gate-drain charge	Q <sub>gd</sub>		-	28	-		
Gate resistance	$R_g$	f = 1 MHz	0.6	3.1	6.2	Ω	
Turn-on delay time	t <sub>d(on)</sub>		-	18	27		
Rise time	t <sub>r</sub>	$\begin{split} V_{DD} = 75 \text{ V}, \text{ R}_L = 5  \Omega, \text{ I}_D &\cong 15 \text{ A}, \\ V_{GEN} = 10 \text{ V}, \text{ R}_g = 1  \Omega \end{split}$	-	44	66		
Turn-off delay time	t <sub>d(off)</sub>		-	72	108	ns	
Fall time	t <sub>f</sub>		-	55	83		
<b>Drain-Source Body Diode Characteristi</b>	cs						
Pulse diode forward current (t = 100 μs)	I <sub>SM</sub>		-	-	100	Α	
Body diode voltage	V <sub>SD</sub>	I <sub>F</sub> = 15 A, V <sub>GS</sub> = 0 V	-	0.85	1.5	V	
Body diode reverse recovery time	t <sub>rr</sub>		-	130	195	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>	L = 15 A dl/dt = 100 A/vo	-	0.71	1.07	μC	
Reverse recovery fall time	t <sub>a</sub>	I <sub>F</sub> = 15 A, dl/dt = 100 A/μs	-	97	-		
Reverse recovery rise time	t <sub>b</sub>		-	33	-	ns	
Body diode peak reverse recovery charge	I <sub>RM(REC)</sub>		-	12	18	Α	

#### Notes

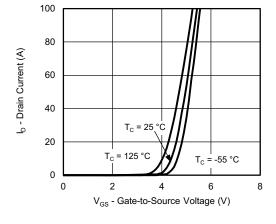
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

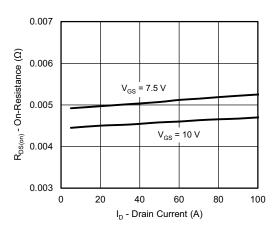




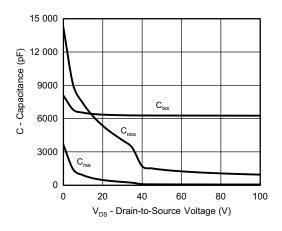
#### **Output Characteristics**



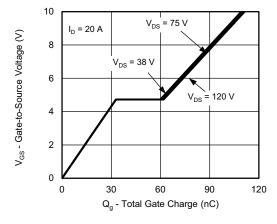
**Transfer Characteristics** 



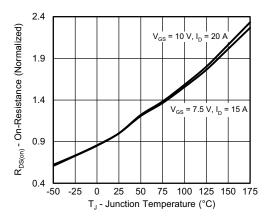
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

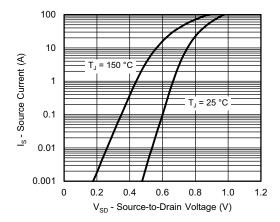


**Gate Charge** 

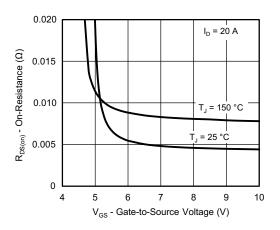


On-Resistance vs. Junction Temperature

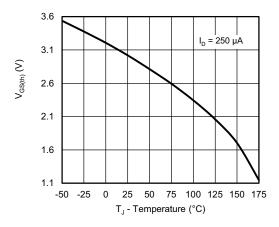




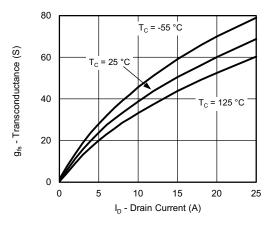
Source-Drain Diode Forward Voltage



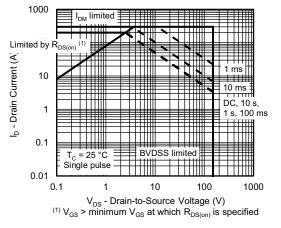
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

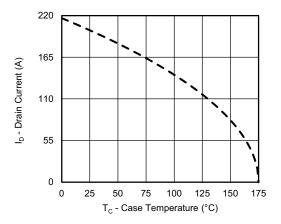


Transconductance

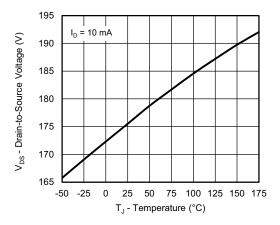


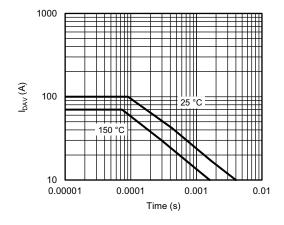
Safe Operating Area, Junction-to-Ambient





#### Current Derating a





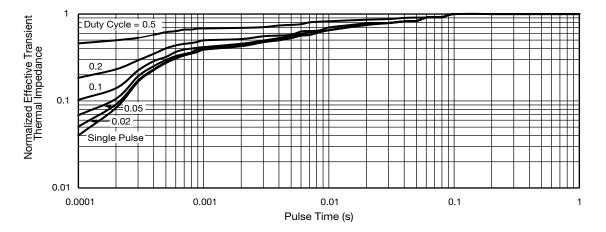
**Drain Source Breakdown vs. Junction Temperature** 

I<sub>DAV</sub> vs. Time

#### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Case

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